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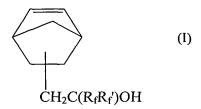
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CLAIMS

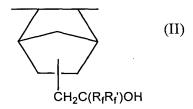
What is claimed is:

1. A composition comprising endo- and exo- 2-(bicyclo[2.2.1]hept-5-en-2-yl)- 2,2-fluoroalkyl-ethan-2-ol whereof the endo/exo concentration ratio is no greater than 5/95, as represented by the structure (I)



wherein the R_f and R_f groups are the same or different fluoroalkyl groups of from 1 to about 10 carbon atoms, or taken together in cyclic form are $(CF_2)_n$ where n is an integer from 2 to 10.

- 2. The composition of Claim 1 wherein the R_f and $R_{f'}$ groups are perfluoromethyl.
 - 3. A polymer made by polymerizing the composition of Claim 1.
- 4. A copolymer made by copolymerizing the composition of Claim 1 and an olefinic comonomer.
 - 5. The copolymer of Claim 4 in which the olefinic comonomer is a fluorolefin.
 - A polymer comprising about 10 mol % to about 60 mole % of a repeat unit derived from a composition comprising endo and exo monomer units represented by structure (II)



wherein the R_f and $R_{f'}$ groups are the same or different fluoroalkyl groups of from 1 to 10 carbon atoms, or taken together in cyclic form are $(CF_2)_n$; n is an integer from 2 to 10; the monomer units of the composition having an endo/exo ratio no greater than 5/95.

7. The polymer of Claim 6 further comprising a unit derived from an olefinic monomer.

- 8. The polymer of Claim 6 in which the olefinic monomer is a fluoroolefin.
- 9. The polymer of Claim 6 wherein at least one of $R_{\rm f}$ and $R_{\rm f'}$ is perfluoromethyl.
- 10. The polymer of Claim 8 wherein said fluoroolefin is selected from the group consisting of the fluoroolefin is selected from the group consisting of tetrafluoroethylene, hexafluoropropylene, chlorotrifluoroethylene, vinylidene fluoride, vinyl fluoride, perfluoro-(2,2-dimethyl-1,3-dioxole), perfluoro-(2-methylene-4-methyl-1,3-dioxolane), CF₂=CFO(CF₂)_tCF=CF₂, where t is 1 or 2, and R_f"OCF=CF₂ wherein R_f" is a fluoroalkyl group of from 1 to 10 carbon atoms.
 - 11. The polymer of Claim 10 wherein said fluoroolefin is tetrafluoroethylene.

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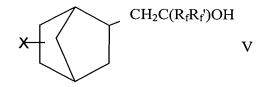
- 12. The polymer of Claim 6 further comprising a unit having a protected acidic group that forms, when photolytically activated, hydrophilic acidic groups.
- 13. The polymer of Claim 12 wherein said protected acidic group is selected from the group consisting of esters capable of forming, or rearranging to, a tertiary cation, esters of lactone, acetal esters, β -cyclic ketone esters, α -cyclic ether esters, methoxy ethoxy ethyl methacrylate, and carbonates formed from a fluorinated alcohol and a tertiary aliphatic alcohol.
- 14. The polymer of Claim 6 further comprising a unit derived from a monomer selected from the group consisting of tert-butyl acrylate, 2-methyl-2-adamantyl acrylate, 2-tetrahydropyranyl acrylate, 2-tetrahydrofuramyl acrylate, and 2-hydroxy-1,1,2-trimethylpropyl ester.
- 15. The polymer of Claim 14 wherein said monomer is t-butyl acrylate or 2-methyl-2-adamantyl acrylate.
- 16. A process for preparing a composition comprising endo- and exo- 2-bicyclo[2.2.1]hept-5-en-2-yl)- 2,2-fluoroalkyl-ethan-2-ol whereof the endo/exo concentration ratio is no greater than about 5/95, the process, comprising the steps of:

contacting in the presence of a source of free radicals a substituted norbornene with $ICH_2C(R_f)(R_f)OH$; wherein said substituted norbornene is represented by the structure (III)

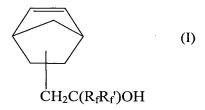
to form an iodine-containing substituted norbornane compound represented by structure (IV);

$$\begin{array}{c} \text{CH}_2\text{C}(R_fR_f)\text{OH} \\ \\ \text{(IV)} \end{array}$$

contacting said iodine-containing compound with a reducing agent to form a substituted norbornane represented by structure (V);



forming an olefin from the substituted norbornane (V) to form a composition comprising endo and exo 2-(bicyclo[2.2.1]hept-5-en-2-yl)- 2,2-perfluoroalkyl-ethan-2-ol, whereof the endo/exo concentration ratio is no greater than 5/95 as represented by the structure (I).



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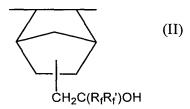
wherein in the foregoing structures the R_f and R_f groups are the same or different fluoroalkyl groups of from 1 to 10 carbon atoms, or taken together in cyclic form are $(CF_2)_n$, n is an integer from 2 to 10, and wherein X is selected from the group consisting of Cl, Br, and R_8SO_2 —O—, where R_8 is an alkyl-, fluoroalkyl, aryl or fluoroaryl radical.

- 17. The process of Claim 16 wherein at least one of R_f and R_f is perfluoromethyl.
 - 18. The process of Claim 16 wherein X is Cl.

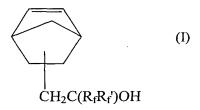
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- 19. The process of Claim 16 wherein the Cl is predominantly in the exo position.
- 20. The process of Claim 16 wherein said iodine-containing compound is contacted with a reducing agent.
- 21. The process of Claim 16 wherein said solvent is selected from the group consisting of water, alcohol, tetrahydrofuran and a glyme; said hydrogenation catalyst is Pd or Pt, and the base is selected from the group consisting of sodium and potassium bicarbonate, sodium and potassium carbonate, and an amine.
- 22. A photoresist suitable for use in the preparation of electronic circuits said photoresist comprising a photoactive agent and a polymer compromising 10 mol-% to 60 mol-% of a repeat unit represented by the structure (II)



and whereof said repeat unit is derived from a composition comprising endo- and exo- 2-(bicyclo[2.2.1]hept-5-en-2-yl)- 2,2-fluoroalkyl-ethan-2-ol, as represented by the structure (I)



wherein the R_f and R_{f'} groups are the same or different fluoroalkyl groups of from 1 to about 10 carbon atoms, or taken together in cyclic form are (CF₂)_n where n is an integer from 2 to 10, whereof the endo/exo ratio is no greater than 5/95.

- 23. The photoresist of Claim 22 wherein at least one of R_f and R_f is perfluoromethyl.
- 24. The photoresist of Claim 22 wherein said polymer further comprises a unit derived from a fluoroolefin selected from the group consisting of tetrafluoroethylene, hexafluoropropylene, chlorotrifluoroethylene, vinylidene fluoride, vinyl fluoride, perfluoro-(2,2-dimethyl-1,3-dioxole), perfluoro-(2-methylene-4-methyl-1,3-dioxolane), $CF_2=CFO(CF_2)_tCF=CF_2$, where t is 1 or 2, and R_f "OCF= CF_2 wherein R_f " is a fluoroalkyl group of from 1 to 10 carbon atoms.
- 25. The photoresist of Claim 24 wherein said fluoroolefin is tetrafluoroethylene.

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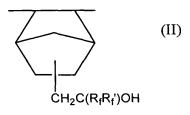
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- 26. The photoresist of Claim 22 wherein said polymer further comprises a unit having a protected acidic group.
- 27. The photoresist of Claim 26 wherein said acidic group is a fluorinated alcohol group.
- 28. The photoresist of Claim 26 wherein said protected acidic group is selected from the group consisting of esters capable of forming, or rearranging to, a tertiary cation, esters of lactone, acetal esters, β -cyclic ketone esters, α -cyclic ether esters, methoxy ethoxy ethyl methacrylate, and carbonates formed from a fluorinated alcohol and a tertiary aliphatic alcohol.
- 29. The photoresist of Claim 22 wherein said polymer further comprises a unit derived from one or more of tert-butyl acrylate, 2-methyl-2-adamantyl acrylate, 2-tetrahydropyranyl acrylate, 2-tetrahydrofuramyl acrylate, and 2-hydroxy-1,1,2-trimethylpropyl ester.
- 30. The photoresist of Claim 22 wherein said unit is derived from tbutyl acrylate or 2-methyl-2-adamantyl acrylate.
- 31. An article comprising a semiconducting substrate having a surface, and a photoresist film disposed upon at least a portion of said surface, said photoresist film comprising a photoactive agent and a polymer compromising 10 mol-% to 60 mol-% of a repeat unit represented by the structure (II)



and whereof said repeat unit is derived from a composition comprising endo- and exo- 2-(bicyclo[2.2.1]hept-5-en-2-yl)- 2,2-fluoroalkyl-ethan-2-ol, as represented by the structure (I)



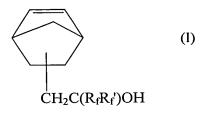
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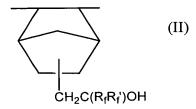
wherein the R_f and R_f groups are the same or different fluoroalkyl groups of from 1 to about 10 carbon atoms, or taken together in cyclic form are $(CF_2)_n$ where n is an integer from 2 to 10, whereof the endo/exo ratio is no greater than 5/95.

- 32. The article of Claim 31 wherein at least one of R_f and R_f is perfluoromethyl.
- 33. The article of Claim 31 wherein said polymer further comprises repeat units derived from a fluoroolefin selected from the group consisting of tetrafluoroethylene, hexafluoropropylene, chlorotrifluoroethylene, vinylidene fluoride, vinyl fluoride, perfluoro-(2,2-dimethyl-1,3-dioxole), perfluoro-(2-methylene-4-methyl-1,3-dioxolane), $CF_2=CFO(CF_2)_tCF=CF_2$, where t is 1 or 2, and R_f "OCF= CF_2 wherein R_f " is a fluoroalkyl group of from 1 to 10 carbon atoms.
- 34. The article of Claim 33 wherein said fluoroolefin is tetrafluoroethylene.
- 35. The article of Claim 31 wherein said polymer further comprises a repeat unit derived from a monomer having a protected acidic group.
- 36. The article of Claim 35 wherein said acidic group is a fluorinated alcohol group.
- 37. The article of Claim 35 wherein said protected acidic group is selected from the group consisting of esters capable of forming, or rearranging to, a tertiary cation, esters of lactone, acetal esters, β -cyclic ketone esters, α -cyclic ether esters, methoxy ethoxy ethyl methacrylate, and carbonates formed from a fluorinated alcohol and a tertiary aliphatic alcohol.
- 38. The article of Claim 31 further comprising a unit derived from a monomer selected from the group consisting of tert-butyl acrylate, 2-

methyl-2-adamantyl acrylate, 2-tetrahydropyranyl acrylate, 2-tetrahydrofuramyl acrylate, and 2-hydroxy-1,1,2-trimethylpropyl ester.

- 39. The article of Claim 38 wherein said monomer is t-butyl acrylate or 2-methyl-2-adamantyl acrylate.
- 40. The article of Claim 31 wherein said substrate comprises silicon.
- 41. A process for preparing a patterned article the process comprising:

forming a target surface by disposing upon a semiconducting substrate a photoresist film comprising a photoactive agent and a polymer compromising 10 mol-% to 60 mol-% of a repeat unit represented by the structure (II)

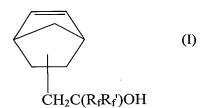


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whereof said repeat unit is derived from a composition comprising endo- and exo- 2-(bicyclo[2.2.1]hept-5-en-2-yl)- 2,2-fluoroalkylethan-2-ol, as represented by the structure (I)



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wherein the R_f and $R_{f'}$ groups are the same or different fluoroalkyl groups of from 1 to about 10 carbon atoms, or taken together in cyclic form are $(CF_2)_n$ where n is an integer from 2 to 10, whereof the endo/exo ratio is no greater than 5/95;

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illuminating said target surface in such a manner as to form a pattern of shadowed and illuminated areas, the illuminating step causing a change in solubility of said polymer;

removing the soluble portions of said polymer, thereby producing a patterned article.

- 42. The process of Claim 41 in which the process further comprises after the illuminating step a step of heating the target surface.
- 43. The process of Claim 41 wherein at least one of R_f and R_f is perfluoromethyl.
- 44. The process of Claim 41 wherein said polymer further comprises a unit derived from a fluoroolefin selected from the group consisting of tetrafluoroethylene, hexafluoropropylene, chlorotrifluoroethylene, vinylidene fluoride, vinyl fluoride, perfluoro-(2,2-dimethyl-1,3-dioxole), perfluoro-(2-methylene-4-methyl-1,3-dioxolane), $CF_2=CFO(CF_2)_tCF=CF_2$, where t is 1 or 2, and R_f "OCF= CF_2 wherein R_f " is a fluoroalkyl group of from 1 to 10 carbon atoms.
- 45. The process of Claim 44 wherein said fluoroolefin is tetrafluoroethylene.
- 46. The process of Claim 41 wherein said polymer further comprises a unit having a protected acidic group that forms, when photolytically activated, hydrophilic acidic groups which enable development of resist coatings.
 - 47. The process of Claim 46 wherein said acidic group is a fluorinated alcohol group.
- 48. The process of Claim 46 wherein said protected acidic group is selected from the group consisting of an ester capable of forming, or rearranging to, a tertiary cation, an ester of lactone, an acetal ester, a β -cyclic ketone ester, an α -cyclic ether ester, a methoxy ethoxy ethyl methacrylate, and a carbonate formed from a fluorinated alcohol and a tertiary aliphatic alcohol.
 - 49. The process of Claim 41 wherein said polymer further comprises a unit derived from a monomer selected from the group consisting of tert-butyl acrylate, 2-methyl-2-adamantyl acrylate, 2-tetrahydropyranyl acrylate, 2-tetrahydrofuramyl acrylate, and 2-hydroxy-1,1,2-trimethylpropyl ester.
 - 50. The process of Claim 49 wherein said monomer is t-butyl acrylate or 2-methyl-2-adamantyl acrylate.
 - 51. The process of Claim 41 wherein said substrate comprises silicon.

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